

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10580087	PECH ET AL.
	Examiner	Art Unit
	Kruer, Stefan	3654

SEARCHED

Class	Subclass	Date	Examiner
242	374, 379.1, 383.2	01/07/2008	SHK
297	480		
280	806		
B60R	22/46		

SEARCH NOTES

Search Notes	Date	Examiner
PLUS	01/07/2008	SHK

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner